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The 23rd Opto-Electronics and Communications Conference

Conference Program & Abstracts

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OECC 2018 Program

Tuesday, July 3

[3D2] 16:00-17:30 Optical Transmitter 1

Session Chair : Nicola Calabretta (TU/e)

3D2-1 16:00-16:30 (30') Invited Modeling Depletion-Type Si Ring Modulators

Woo-Young Choi¹ , Minkyu Kim¹ , Myungjin Shin¹ , Byung-Min Yu¹ , Christian Mai² , Stefan Lischke² , and Lars Zimmermann² .

1 Yonsei Univ., Korea, 2 IHP, Germany

For achieving monolithic integration of Si electronics and photonics, accurate and convenient-to-use models for Si photonic devices are very important. We present such amodel for depletion-type Si ring modulators.

Room D (302) Room E (Halla Hall A) Room F (303)

[3E2] 16:00-17:30

Integrated Photonics 1 *Session Chair : Benjamin J. Eggleton (The Univ. of Sydney)*

3E2-1 16:00-16:30 (30') Invited Silicon Nitride (TriPleX™) based Photonic Integrated Circuits for a Broad Range of Application Modules

Arne Leinse

LioniX Int'l, Netherlands An overview of recent developments of the SiN based TriPleX™ Photonic-Integrated-Circuit technology is given. The unique features of the technology are explained and application examples in avariety of wavelength ranges are shown.

[3F2] 16:00-17:30 [Symposium 1] 10Giga Internet and Broadband Access *Session Chair : Xiang Liu (Huawei) T. Nirmalathas (The Univ. of Melbourne)*

3F2-1 16:00-16:30 (30') Invited State of Broadband Access and High Speed PON *Hyung Jin Park KT, Korea*

3D2-2 16:30-17:00 (30') Invited

Ultra-Low-Power Microring Modulators for PAM and WDM Links

Wei Shi and Yelong Xu

Université Laval, Canada

We review our recent results on low-power microring modulators for pulse-amplitude modulation and high-quality frequency comb generation. This singlelaser WDM solution is promising for next-generation optical interconnects.

3D2-3 17:00-17:15 (15')

A Wavelength Stabilization Integrated Circuit for 25-Gb/s Si Micro-Ring Modulator

Min-Hyeong Kim¹ , Lars Zimmermann² , and Woo-Young Choi1

1 Yonsei Univ., Korea, 2IHP, Germany

We demonstrate wavelength stabilization of Si microring modulator (MRM) with an integrated circuit custom-designed in 0.25-μm BiCMOS technology. Our circuit controls the MRM temperature so that it can have the maximum optical modulation amplitude with 25-Gb/s modulation.

3D2-4 17:15-17:30 (15') An Actively Mode-Locked Laser based on a 5th Order Micro-Ring Resonator

Qihong Wu¹, Yuhua Li², Shaohao Wang³, Qian Li¹, and *Sai Tak Chu2*

¹ Peking Univ., China, ²City Univ. of Hong Kong, China,
³ Fuzhou Univ. China *Fuzhou Univ., China*

We present a mode locked laser configuration with an integrated 5th order micro-ring resonator, where highly stable pulse trains with single and multiple pulses per period have been achieved.

Kyong Hon Kim¹ , Yudeuk Kim¹ , Yoohan Kim¹ , Dong

3E2-2 16:30-17:00 (30') Invited Integrated Polarization Diversity Devices

Wook Kim¹, and Moon Hyoek Lee² *1 Inha Univ., Korea, 2 Heinrich Hertz Inst., Germany* Integrated polarization diversity devices, such as polarization beam splitter, polarization rotator, and polarizer, are very important in silicon-based photonic integrated circuits. The integrated polarization diversity devices are introduced, and experimentally demonstrated results are reported.

3F2-2 16:30-17:00 (30') Invited

Broadband Access in Japan and Flexible Optical Access

Sangyeup Kim NTT Corp., Japan

3E2-3 17:00-17:15 (15')

Two- and Three-Dimensional Polymer Directional Coupler for High-Density Optical Interconnects at 1550 nm

Xiao Xu, Lin Ma, and Zuyuan He Shanghai Jiaotong Univ., China We demonstrate two- and three-dimensional singlemode polymer directional coupler directly inscribed using a micro-dispenser. We successfully fabricated two-core couplers with splitting ratios of 0.95 and 0.52 and three-dimensional couplers operating at 1550 nm.

3E2-4 17:15-17:30 (15')

Analytical Investigation of Generic Form Expressing Adaptive Dispersion of Optical Fractional Fourier Transform Circuit

Tomohiro Naganuma and Hiroyuki Uenohara Tokyo Inst. of Tech., Japan

We clarified the regularity of the dispersion performance of an optical fractional Fourier transform circuit, realizing variable dispersion compensation in an optical OFDM system. The generic form of dispersion performance is presented.

3F2-3 17:00-17:30 (30') Invited Deployment of 10G Internet and Broadband Access: Korean Story

Sung-uk Rha NIA, Korea

Modeling Depletion-Type Si Ring Modulators

Woo-Young Choi, Minkyu Kim, Myungjin Shin, Byung-Min Yu,

Christian Mai*, Stefan Lischke*, and Lars Zimmermann*. Department of Electrical and Electronic Engineering, Yonsei University, Seoul Korea * IHP, Im Technologiepark 25, 15236 Frankfurt (Oder), Germany

Abstract

For achieving monolithic integration of Si electronics and photonics, accurate and convenient-to-use models for Si photonic devices are very important. We present such a model for depletion-type Si ring modulators.

Depletion-type Si ring modulators (RMs) have a very large potential for applications in high-performance optical interconnect systems, since they have the large modulation bandwidth and the small size [1, 2]. For optimal design of electronic-photonic ICs containing both Si RMs and electronic circuits, such Si RM models are required that are easy to use and compatible with standard IC design tools. In addition, the extraction of model parameters should be simple and straight-forward.

Various models for Si RM have been reported [3-5]. However, they either require a substantial amount of computation time or not very compatible with the standard IC design tools. A new approach that overcomes these problems has been proposed [6].

Fig. 1 (a) Chip photo of a fabricated Si RM and (b) Measured and simulated transmission characteristics at different V_{Bias} . [6]

Fig. 1(a) shows the structure of a Si RM used for the present investigation. It is fabricated by IHP Si photonics foundry service. Its characteristics can be accurately modeled by the coupled-mode equations [7]:

$$
\frac{d}{dt}a(t) = \left(j\omega_r - \frac{1}{\tau}\right)a(t) - j\sqrt{\frac{2}{\tau_e}}E_i(t),\tag{1}
$$

$$
E_o(t) = E_i(t) - j \sqrt{\frac{2}{\tau_e}} a(t).
$$
 (2)

In the above equations, $a(t)$ is the optical energy amplitude stored in the ring resonator, $E_i(t)$ and $E_o(t)$ are the input and the output optical field, respectively. ω_r is the ring resonance angular frequency given as ω_r = $2\pi \text{mc}/n_{res}L$, where m is an integer representing the resonance mode number, c is the velocity of light in vacuum, L is the ring circumference, and n_{res} is the effective index of the ring waveguide at the resonance. *τ* is the decay time constant for $a(t)$, given as $1/\tau = 1/\tau$, τ where τ_e and τ_l , represent the decay time constant in a(t) due to the coupling loss and input optical field, respectively.

If numerical values of three parameters (n_{eff} , τ_l , and τ_e) are known, the RM characteristics can be well modeled. For the extraction of these values, the minimum mean square error method is used for fitting the steady-state equation to the measured transmission characteristics. Fig. 1(b) shows the measured normalized transmission characteristics at three different bias voltages. Dots are measured results and solid lines are fitted results with extracted values.

Fig. 2. Measured and simulated E/O frequency responses for different detuning values. [8]

With these parameters, the Si RM small-signal modulation frequency response in the s-domain can be derived from the couple-mode equations as [8]

$$
G \cdot \frac{s + 2/\tau_i}{s^2 + (2/\tau)s + D^2 + 1/\tau^2} \tag{3}
$$

where *D* represents how much the input light angular frequency is detuned from the resonance angular frequency, *G* is the response gain given in terms of n_{eff} , τ_e , *τl* and *D*. Fig. 2 confirms the accuracy of this small-signal model with the measured results.

In order to implement the large-signal RM model which can provide the RM transient modulation characteristics, the coupled-mode equations can be

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numerically solved in Verilog-A [5]. However, this approach has limitation in that its simulation takes quite a long time for achieving high accuracy. A piece-wise linear model based on the equivalent circuit representing Eq. 3 can provide much fast computation in SPICE environment [6].

Fig. 3(a) A large-signal equivalent circuit model of Si RM and (b) Simulated (upper) and measured (lower) eye-diagrams for $2-V_{pp}$, 25 -Gbps, 2^{31} -1 PRBS input signal. [6]

Fig. 3(a) shows the equivalent circuit. It contains a block for parasitic components due to interconnects and pads, another for the electrical elements of the core p-n junction $(R_s$ and C_i), and the third for a lossy LC tank emulating the Si RM small-signal modulation frequency response. Numerical values for the parasitic components as well as R_s and C_i can be easily determined by the standard electrical s-parameter measurement. Numerical values for R_1 , R_2 , C and L are determined from τ_l , τ and D. *g* is a unit-converting scaling factor. Varactors and variable resistors are used for accounting for bias-voltage dependence of these parameters. Fig. 3(b) shows the simulated eye-diagram (upper) and the measured result (lower), confirming the accuracy of our model.

Fig. 4(a) Si Photonic transmitter based on Photonic BiCMOS technology, (b) Vertical eye opening for various R_L and Itail values, and (c) Simulated eye-diagrams at different I_{tail} and R_L combination. [6]

This new model can be very easily used for cosimulation of electronic circuits and Si RMs. Fig. 4(a) shows a schematic diagram for an integrated 25-Gbps Si photonic transmitter (Si RM and driver). Such an electronic-photonic integrated circuit can be fabricated monolithically with IHP's Photonic BiCMOS technology, which provides high-performance 0.25-μm SiGe BiCMOS circuits and Si photonic components on the same Si platform [9]. Fig. 4(b) shows the simulated vertical eye opening normalized to input optical power at different values of I_{tail} and R_L , two key parameters in the driver design that determine eye-opening, power consumption, and bandwidth. Fig. 4(c) shows simulated eye-diagrams at three different conditions represented by point A, B, C in Fig. 4(b). Clearly, the optimal combination of I_{tail} and R_L can be easily determined.

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